



(1) Publication number:

0 382 428 A3

(12)

## **EUROPEAN PATENT APPLICATION**

(21) Application number: 90301122.9

(51) Int. Cl.5: G01R 1/04

2 Date of filing: 02.02.90

(30) Priority: 10.02.89 US 309698

Date of publication of application:16.08.90 Bulletin 90/33

Designated Contracting States:
AT BE CH DE DK ES FR GB GR IT LI LU NL SE

- ©3 Date of deferred publication of the search report: 10.07.91 Bulletin 91/28
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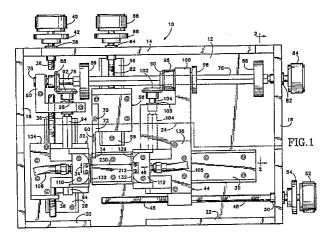
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- (54) Test fixture for microstrip assemblies.
- © A test fixture (10) for testing microstrip assemblies and similar electronic circuit components and assemblies under application of high-frequency signals introduced through launchers (110, 112) whose positions are adjustable in the test fixture to accommodate circuit assemblies of different sizes and different geometry includes an easily operated rapid connector positioning mechanism (32, 44) that moves connectors (132) which complete electrical connection between outer conductors (127) of the

launchers and a ground plane conductor (130) of a microstrip assembly (114). The connectors (132) also lift the microstrip assembly (114) and support it while electrical connection is completed, without the need for a carrier beneath the test assembly. A lid (24) is moved in coordination with operation of the connector positioning mechanism to provide electrical contact to a third point on the upper face (122) of a circuit assembly (114) to be tested.





## EUROPEAN SEARCH REPORT

EP 90 30 1122

DOCUMENTS CONSIDERED TO BE RELEVANT				
Category		h indication, where appropriate, vant passages		evant CLASSIFICATION OF THE claim APPLICATION (Int. CI.5)
D,Y A Y	US-A-4 280 112 (EISENH) * Column 6, lines 15-68; figu-	ures 1-3 * -	28,2 1-27 28,2	R 31/28 H 01 P 5/08 G 01 R 1/04
'	* Column 2, lines 1-14; figur		., 20,2	
A A	US-A-4 346 355 (RAYTHE * Abstract; figures 2,4,8 *	ON)	1-27 1-29	
А	US-A-3 662 318 (JC. DE	CUYPER) 		
				TECHNICAL FIELDS SEARCHED (Int. Cl.5)
	·			G 01 R H 01 P
	The present search report has I	peen drawn up for ail claims		
-	Place of search	Date of completion of	f search	Examiner
	The Hague	12 April 91		IWANSSON K.G.
X: particularly relevant if taken alone Y: particularly relevant if combined with another document of the same catagory A: technological background  the filing date D: document cit L: document cit			cited in the application cited for other reasons f the same patent family, corresponding	